

# Search Notes



Application/Control No.

10/698,546

Examiner

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Applicant(s)/Patent under Reexamination

IKEGAMI, NAOKATSU

Art Unit

1765

## SEARCHED

Class	Subclass	Date	Examiner
438	700	7/15/2005	KCC
	706		
	710		
	712		
	714		
	723		
	724		
438	725	7/15/05	KCC

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
peruse parent case East Key words search USPT, USPT- pub. Epo, JPO, IBM-TDB	7/15/05	KCC
Derwent, inventor search	7/15/05	KCC